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			PARKER, JEFFREY ALAN	
1200 SEVENT DENVER, CO			ART UNIT	PAPER NUMBER
		2629		
			NOTIFICATION DATE	DELIVERY MODE
			12/31/2009	ELECTRONIC

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

Notice of the Office communication was sent electronically on above-indicated "Notification Date" to the following e-mail $\,$ address(es):

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Office Action Summary

Application No.	Applicant(s)	
10/584,503	VAN DER TUIJN ET AL.	
Examiner	Art Unit	
JEFFREY PARKER	2629	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) OR THIRTY (30) DAYS, WHICHEVER IS LONGER FROM THE MAILING DATE OF THIS COMMUNICATION

- Exter after - If NC - Failu Any	classions of time may be available under the provisions of 3f CFR 1.156(a). In no event, I ere SK (fig MONTH's from the mailing date of the communication. NO period for reply is specified above, the maximum statutory period will apply and will rep- lative to reply within the sol or extended period for reply bit. by statute, cause the application ty reply received by the Office later than three months after the mailting date of this communication term disjustment. See 3f 761R 1.704(b).	nowever, may a reply be timely filed pire SIX (6) MONTHS from the mailing date of this communication. on to become ABANDONED (35 U.S.C. § 133).				
Status						
1)🛛	Responsive to communication(s) filed on 14 September 2005	<u>9</u> .				
2a)⊠	☐ This action is FINAL. 2b)☐ This action is non-	final.				
3)□	Since this application is in condition for allowance except for					
	closed in accordance with the practice under Ex parte Quayl	e, 1935 C.D. 11, 453 O.G. 213.				
Disposit	ition of Claims					
4)⊠	Claim(s) 1-11 is/are pending in the application.					
	4a) Of the above claim(s) is/are withdrawn from consideration.					
5)□	5) Claim(s) is/are allowed.					
	Claim(s) <u>1-11</u> is/are rejected.					
	Claim(s) is/are objected to.					
8)[_	Claim(s) are subject to restriction and/or election requ	irement.				
Applicat	ation Papers					
9)	The specification is objected to by the Examiner.					
10)🛛	The drawing(s) filed on 22 June 2006 is/are: a) accepted of	or b) objected to by the Examiner.				
	Applicant may not request that any objection to the drawing(s) be h	eld in abeyance. See 37 CFR 1.85(a).				
11)	Replacement drawing sheet(s) including the correction is required if The oath or declaration is objected to by the Examiner. Note					
Priority (v under 35 U.S.C. § 119					
12)🖾	Acknowledgment is made of a claim for foreign priority under	35 U.S.C. § 119(a)-(d) or (f).				
a)	a)⊠ All b)□ Some * c)□ None of:					
	 Certified copies of the priority documents have been received. 					
	2. Certified copies of the priority documents have been received in Application No					
	Copies of the certified copies of the priority documents	· · ·				
	application from the International Bureau (PCT Rule 1	,				
* 5	See the attached detailed Office action for a list of the certified	copies not received.				
Attachmen	ent(s)					
		Interview Summary (PTO-413) Paper No(s)/Mail Date				
3) Information Disclosure Statement(s) (PTO/C5/08) 5) Notice of Informat Patent Application						
	Paper No(s)/Mail Date <u>9/14/2009</u> . 6) Other:					

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DETAILED ACTION

Response to Arguments

Applicant's Amendment filed on September 14, 2009 has been considered. Claims 1-11 are currently pending.

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1, 8, 10, and 11 are rejected under 35 U.S.C. 102(b) as being anticipated by U.S. Publication 2003/0081697 to <u>Little</u>.

As per claims 1 and 8, <u>Little</u> discloses a method/system of generating an adaptive slicer threshold from a received demodulated signal (Abstract: "An adaptive slicer threshold generation system includes a first moving average filter to determine a first average value of a first binary signal"), the method comprising

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the steps of: detecting a plurality of maximum values of the signal over a predetermined period, for at least two periods (See Figs. 1 and 4 First moving average filter 410 and paragraph [0026]: "The first moving average filter 410 averages binary ones 110 that the adaptive slicer threshold generation system 400 receives." Binary ones are the "maximum values" of a binary signal), and detecting a plurality of minimum values of the signal over a predetermined period, for at least two periods (See Figs. 1 and 4 Second moving average filter 420 and paragraph [0027]: "The second moving average filter 40 averages binary zeros 120 that the adaptive slicer threshold generation system 400 receives." Binary zeroes are the "minimum values" of a binary signal), wherein the method comprises the steps of: averaging the plurality of detected maximum values and averaging the plurality of detected minimum values (See Fig. 4 Combiners 415 and 465 and paragraphs [0026] and [0027] describing obtaining a moving average of ones, i.e. maximum values, and zeroes, i.e. minimum values), and calculating the slicer threshold from these average minimum and maximum. values (See Fig. 4 Combiner 430 and paragraph [0025] describing that the combiner 430 combines the first average value [of maximums] and second average value [of minimums] to generate a slicer threshold).

As per claim 10, <u>Little</u> discloses the system according to claim 8, wherein the first and/or second detectors are a maximum peak detector and a minimum peak detector, respectively (See paragraph [0029] describing the operations of

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elements 450, 460, and 470 which determine if a received binary signal is a binary one, i.e. maximum, or a binary zero, i.e. minimum).

As per claim 11. Little discloses the system according to claim 8, wherein the system comprises a bit level detector associated with said at least one memory in order to activate the storage of a new minimum or maximum value only if a bit level change has been detected (minimum value - paragraph [0032]: "If the received binary signal, v.sub.in(n), of the minimum comparator 505 of the minimum detector 510 is less than the delayed output signal, v.sub.out(n-1), of the minimum comparator 505 that has passed through both the combiner 515 and the delay element 535, then the minimum comparator 505 outputs the received binary signal, v.sub.in(n), of the minimum comparator 505. Thus, the output signal, v.sub.out(n), of the minimum comparator 505 substantially equals the received binary signal, v.sub.in(n), of the minimum comparator 505. In this case, the received binary signal, v.sub.in(n), of the minimum comparator 505 is preferably stored in a storage element that may be coupled to the output node of the minimum comparator 505. Storage of the received binary signal, v.sub.in(n). of the minimum comparator 505 occurs when the minimum comparator 505 outputs the output signal, v.sub.out(n), that substantially equals the received binary signal, v.sub.in(n), of the minimum comparator 505. The storage element may be the combiner 515; however, any other suitable device may be used."; similarly for maximum value, see paragraph [0036]).

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Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

The factual inquiries set forth in *Graham* v. *John Deere Co.*, 383 U.S. 1, 148 USPQ 459 (1966), that are applied for establishing a background for determining obviousness under 35 U.S.C. 103(a) are summarized as follows:

- Determining the scope and contents of the prior art.
- Ascertaining the differences between the prior art and the claims at issue.
- 3. Resolving the level of ordinary skill in the pertinent art.
- Considering objective evidence present in the application indicating obviousness or nonobviousness.

Claims 2-4 and 9 rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Publication 2003/0081697 to <u>Little</u> in view of U.S. Patent 4,709,274 to Tanioka.

As per claim 2, <u>Little</u> teaches the method according to claim 1. <u>Little</u> teaches wherein the averages of the maximum and minimum values are calculated using a running average over the n last successive detected maximum

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or minimum values, n being a ... integer greater than 1 (maximum average paragraph [0026]: "The first moving average filter 410 averages binary ones 110 (see FIG. 1 and FIG. 2) that the adaptive slicer threshold generation system 400 receives. The first moving average filter 410 preferably includes a first delay element 405, a combiner 415, a gain element 435, and a second delay element 445. The first delay element 405 and the combiner 415 each receive the binary signal, v.sub.in(n). The combiner 415 combines a delayed binary signal, v(n-1), which has passed through the first delay element 405, with the received binary signal, v.sub.in(n), and preferably a leakage signal, v.sub.L(n-1). The leakage signal, v.sub.L(n-1), is a sample of the output signal, v.sub.out(n), of the combiner 415 that has passed through both the gain element 435 and the second delay element 445. The output signal, v.sub.out(n), of the combiner 415 preferably is stored in a storage element."; similarly for minimum average, see paragraph [0027]). Little does not teach N being a predetermined integer greater than 1.

However, Tanioka teaches N being a predetermined integer greater than 1 (column 20, lines 51-66: "In general, it is considered that the slice level for pel density signal binarization is preferably selected to be 1/2(DAmax+DAmin).

However, the values of DAmax and DAmin are those based on the image area having a size of 1/16 mm.times.1 mm, and it is not always suitable to select a slice level based only on the values of DAmax and DAmin. Furthermore, as in a conventional apparatus, when a slice level is determined by prescan, if the background is discriminated by visual observation, the average value of pel

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densities within a relatively wide range is calculated. In the apparatus of the present application, although the basic operation is a sequential operation type, the incorporation of a CPU allows averaging of the image area for a wider range of image by adding previous data to the new pel density average data for 4 main scans."; <u>Tanioka</u> teaches 4 repetitions for the running average used to calculated a slice level).

It would have been obvious to one of ordinary skill in the art at the time of the invention to recognize the application of the predetermined integer of Tanioka to the running average of Little modified so that the running average only calculates the previous 4 samples for the purpose of calculating a moving average with small memory consumption.

As per claim 3, <u>Little</u> in view of <u>Tanioka</u> teaches the method according to claim 2. <u>Tanioka</u> teaches wherein n ranges from 2 to 6 (column 20, lines 51-66: "In general, it is considered that the slice level for pel density signal binarization is preferably selected to be 1/2(DAmax+DAmin). However, the values of DAmax and DAmin are those based on the image area having a size of 1/16 mm.times.1 mm, and it is not always suitable to select a slice level based only on the values of DAmax and DAmin. Furthermore, as in a conventional apparatus, when a slice level is determined by prescan, if the background is discriminated by visual observation, the average value of pel densities within a relatively wide range is calculated. In the apparatus of the present application, although the basic operation is a sequential operation type, the incorporation of a CPU allows

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averaging of the image area for a wider range of image by adding previous data to the new pel density average data for 4 main scans.").

As per claim 4, <u>Little</u> in view of <u>Tanioka</u> teaches the method according to claim 3. <u>Tanioka</u> teaches wherein n is equal to 4 (column 20, lines 51-66: "In general, it is considered that the slice level for pel density signal binarization is preferably selected to be 1/2(DAmax+DAmin). However, the values of DAmax and DAmin are those based on the image area having a size of 1/16 mm.times.1 mm, and it is not always suitable to select a slice level based only on the values of DAmax and DAmin. Furthermore, as in a conventional apparatus, when a slice level is determined by prescan, if the background is discriminated by visual observation, the average value of pel densities within a relatively wide range is calculated. In the apparatus of the present application, although the basic operation is a sequential operation type, the incorporation of a CPU allows averaging of the image area for a wider range of image by adding previous data to the new pel density average data for 4 main scans.").

As per claim 9, <u>Little</u> teaches the system according to claim 8. <u>Little</u> teaches wherein it further comprises at least one ... memory to store said several maximum values and said several minimum values to be averaged (maximum values - paragraph [0026]: "The first delay element 405 and the combiner 415 each receive the binary signal, v.sub.in(n)... The output signal, v.sub.out(n), of the combiner 415 preferably is stored in a storage element. The storage element

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may be the combiner 415; however, any other suitable device may be used."; similarly for minimum value, see paragraph [0027]). <u>Little</u> does not teach wherein it further comprises at least one FIFO memory.

However, <u>Tanioka</u> teaches wherein it further comprises at least one FIFO memory (column 22, lines 8-15: "In step S10, the slice level Ln+1 for the (n+1)st pel block is calculated in accordance with the equation (2) based on the slice level Ln for the nth pel block, DAmax.sub.n, DAmin.sub.n, and the number N of blocks to be considered. In steps S11 and S12, the calculated slice level Ln+1 is shifted in a register now storing the slice level Ln, and is supplied to a comparator 112.")

It would have been obvious to one of ordinary skill in the art at the time of the invention to recognize the application of the predetermined integer of Tanioka to the running average of Little modified so that the running average only calculates the previous 4 samples for the purpose of calculating a moving average with small memory consumption.

Claims 5-7 rejected under 35 U.S.C. 103(a) as being unpatentable over U.S. Publication 2003/0081697 to <u>Little</u> in view of U.S. Patent 1,566,169 to Layrenov.

As per claim 5, <u>Little</u> teaches the method according to claim 1, wherein the step of detecting a maximum value comprises the operations of: detecting a

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maximum peak of the signal during the predetermined period (First moving average filter 410; paragraph [0026]: "The first moving average filter 410 averages binary ones 110 (see FIG. 1 and FIG. 2) that the adaptive slicer threshold generation system 400 receives."), ..., and holding the value of the detected maximum peak as the maximum value over the predetermined period (paragraph [0026]: "The first delay element 405 and the combiner 415 each receive the binary signal, v.sub.in(n)... The output signal, v.sub.out(n), of the combiner 415 preferably is stored in a storage element. The storage element may be the combiner 415: however, any other suitable device may be used.").

Little does not teach the maximum signal peak corresponding to a point where the signal first-order derivative is zero and the signal second-order derivative has a negative value.

However, <u>Lavrenov</u> teaches the maximum signal peak corresponding to a point where the signal first-order derivative is zero and the signal second-order derivative has a negative value (Fig. 2; page 5, lines 24-31: "As this takes place, the second order derivative changes from positive to negative at the point corresponding to the maximum value of the first derivative. When the first order derivative reaches zero (region C), the stage of complete charging is indicated and the storage battery is disconnected from the charging current supply means.").

It would have been obvious to one of ordinary skill in the art at the time of the invention to recognize the application of the signal maximum locating

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technique of <u>Lavrenov</u> to the slice threshold detector of <u>Little</u> modified so that the maximum of each "1" bit can be detected accurately by the slice detector.

As per claim 6, <u>Little</u> teaches the method according to claim 1. <u>Little</u> teaches wherein the step of determining the minimum value comprises the operations of: detecting a minimum peak of the signal during the predetermined period (Second moving average filter 420; paragraph [0027]: "The second moving average filter 40 averages binary zeros 120 (see FIG. 1 and FIG. 2) that the adaptive slicer threshold generation system 400 receives."), ..., and holding the value of the detected minimum peak as the minimum value over the predetermined period (paragraph [0027]: "The first delay element 455 and the combiner 465 each receive the binary signal, v.sub.in(n)... The output signal, v.sub.out(n), of the combiner 465 preferably is stored in a storage element. The storage element may be the combiner 465; however, any other suitable device may be used.").

Little does not teach the minimum signal peak corresponding to a point where the signal first-order derivative is zero and where the signal second-order derivative has a positive value.

However, <u>Lavrenov</u> teaches the minimum signal peak corresponding to a point where the signal first-order derivative is zero and where the signal second-order derivative has a positive value (Fig. 2; page 5, lines 24-31: "As this takes place, the second order derivative changes from positive to negative at the point corresponding to the maximum value of the first derivative. When the first order

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derivative reaches zero (region C), the stage of complete charging is indicated and the storage battery is disconnected from the charging current supply means."; One of ordinary skill in the art would appreciate that to find the minimum rather than the maximum, the first order derivative would also be zero and the second order derivative would change from negative to positive).

It would have been obvious to one of ordinary skill in the art at the time of the invention to recognize the application of the signal maximum locating technique of <u>Lavrenov</u> to the slice threshold detector of <u>Little</u> modified so that the maximum of each "1" bit can be detected accurately by the slice detector.

As per claim 7, <u>Little</u> in view of <u>Lavrenov</u> teaches the method according to claim 5. <u>Little</u> teaches wherein a new detected maximum value is used to calculate the average maximum value only if a minimum peak has been detected during the previous predetermined period (paragraph [0036]: "If the received binary signal, v.sub.in(n), of the peak comparator 555 of the peak detector 520 is more than the delayed output signal, v.sub.out(n-1), of the peak comparator 555 that has passed through both the combiner 565 and the delay element 585, then the peak comparator 555 outputs the received binary signal, v.sub.in(n), of the peak comparator 555."), and a new detected minimum value is used to calculate the average minimum value only if a maximum peak has been detected during the previous predetermined period (paragraph [0032]: "If the received binary signal, v.sub.in(n), of the minimum comparator 505 of the minimum detector 510 is less than the delayed output signal, v.sub.out(n-1), of the minimum comparator

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505 that has passed through both the combiner 515 and the delay element 535, then the minimum comparator 505 outputs the received binary signal, v.sub.in(n), of the minimum comparator 505.").

Response to Arguments

Applicant's arguments filed September 14, 2009 have been fully considered but they are not persuasive.

Applicant argues that absent from Little is the use of an average of several detected maximum values and the average of several detected minimum values. The Examiner respectfully disagrees. Fig. 1 shows the binary ones and zeroes that are detected in a received signal over time. A binary signal contains two possible values: a "one" which is the signal's maximum, and a "zero" which is the signal's minimum. In Fig. 4 and paragraphs [0026]-[0027], Little describes calculating a moving average of the voltage of the signal's detected ones, maximums, and zeroes, minimums, and calculating the slicer threshold as the voltage between the averaged maximum and averaged minimum. This threshold is constantly changing due to the new measurements of the voltages of the ones and zeroes detected in the signal.

Applicant argues that Little only shows using a single maximum binary "0" and a single minimum "1" in a second embodiment which correlates to a description in Applicant's background. This may be true of the second

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embodiment, but this is not the embodiment relied upon for the rejection, and therefore does not discredit Little as a reference for the rejection.

In response to Applicant's argument that the references fail to show certain features of applicant's invention, it is noted that the features upon which applicant relies (i.e. the benefit of reducing the slicer's sensitivity to noise compared to the background method) are not recited in the rejected claim(s). Although the claims are interpreted in light of the specification, limitations from the specification are not read into the claims. See *In re Van Geuns*, 988 F.2d 1181. 26 USPQ2d 1057 (Fed. Cir. 1993).

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

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Any inquiry concerning this communication or earlier communications from the examiner should be directed to JEFFREY PARKER whose telephone number is (571) 270-5161. The examiner can normally be reached on M-F 8:00-5:00.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Richard Hjerpe can be reached on (571) 272-7691. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

/JAP/ /Temesghen Ghebretinsae/ Primary Examiner, Art Unit 2611 12/21/09 OAB